

JFW



In re Application of:

Satoru Miyauchi

Serial No.: 10/719,386

Filed: November 21, 2003

For: METHOD AND APPARATUS FOR
ANALYZING BRAIN FUNCTIONS

Patent Examiner: Unknown

Group Art Unit: 3732

July 1, 2005

Irvine, California 92614

**SUPPLEMENTAL
INFORMATION DISCLOSURE STATEMENT**

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313

Dear Sir:

In an attempt to fully comply with the duty of disclosure set forth in 37 C.F.R. § 1.56 and in conformance with 37 C.F.R. §§ 1.97 and 1.98, applicant wishes to bring to the attention of the U.S. Patent Office the following references, which was found during the prosecution of a co-pending Japanese Patent Application:

WIPO/PCT International Publication No. WO 02/13689
Japanese Patent Publication No. 11-056810 w/English translation

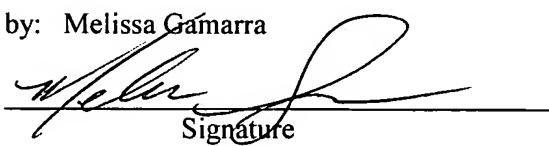
Copies of the references and a form PTO-A820 are attached.

The undersigned attorney hereby certifies that each item contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart international application not more than three months prior to filing this statement.

If the Examiner believes that a telephone conference would help further the prosecution of this case, he is respectfully requested to contact the undersigned attorney at the listed telephone number.

I hereby certify that this correspondence is being deposited with the U.S. Postal Service as first class mail in an envelope addressed to: Mail Stop Amendment, Commissioner for Patent, PO Box 1450, Alexandria, VA 22313-1450, on July 1, 2005

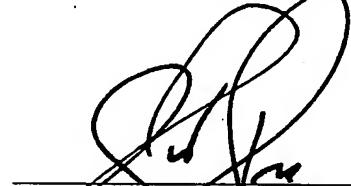
by: Melissa Gamarra



Date of Signature: July 1, 2005

Very truly yours,

SNELL & WILMER LLP



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949/253-4920

INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)



Docket Number (Optional)
43521-1400

Application Number
10/719,386

Applicant(s)
Satoru Miyauchi

Filing Date
11/21/2003

Group Art Unit
3732

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
	WO 02/13689	21.02.2002	WIPO/PCT			✓	
	11-056810	02.03.1999	JAPAN			✓	

OTHER DOCUMENTS *(Including Author, Title, Date, Pertinent Pages, Etc.)*

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.